

Search Notes

Application/Control No.

10/015,372

Examiner

Kerri M. Rose

Applicant(s)/Patent under
Reexamination

NAKATSUGAWA ET AL.

Art Unit

2616

SEARCHED

Class	Subclass	Date	Examiner
370	310, 313, 328, 329, 351, 392	3/3/2006	KMD
370	393, 400	3/3/2006	KMD
370	432, 465	3/3/2006	KMD
370	475	3/3/2006	KMD
455	435.1	3/3/2006	KMD
455	432.1	3/3/2006	KMD
Above	Updated	7/21/2006	KMR
Above	Updated	12/5/2006	KMR
Above	Updated	8/10/2007	KMR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STIC PLUS	3/6/2006	KMD
East, IEEE - see printouts	3/6/2006	KMD
East - see printout	7/21/2006	KMR
Combined citation search: 2005/0053054	7/21/2006	KMR
Combined citation search: 2002/0186679	12/5/2006	KMR
East - see printout	12/12/2006	KMR
370/331, 338, 401; 455/435.1, 432.1, 433, 436 (text search only - see printout)	12/12/2006	KMR
Combined citation search: 2004/0073642; 2003/0026241	12/12/2006	KMR

Search Notes (continued)

Application/Control No.

10/015,372

Examiner

Kerri M. Rose

Applicant(s)/Patent under
Reexamination

NAKATSUGAWA ET AL.

Art Unit

2616

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
370/331, 338, 401 (text only - see printout) UPDATED and combined citation search: 6,999,437	8/10/2007	KMR
379/93.06, 93.08, 242 (text only - see printout) UPDATED	8/10/2007	KMR